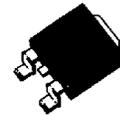
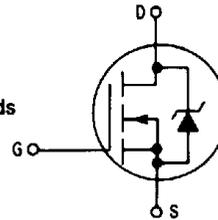
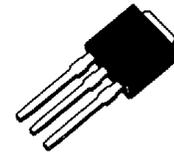


**MOTOROLA**  
**SEMICONDUCTOR**  
**TECHNICAL DATA**
*Designer's Data Sheet*
**Power Field Effect Transistor**
**N-Channel Enhancement-Mode**
**Silicon Gate**
**DPAK for Surface Mount or  
Insertion Mount**

**MTD2N20**
**TMOS POWER FETs**  
**2 AMPERES**  
 $R_{DS(on)} = 1.5 \text{ OHMS}$   
**200 VOLTS**

These TMOS Power FETs are designed for high speed, low loss power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds
- Low  $R_{DS(on)}$  — 1.5  $\Omega$  max
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads
- Low Drive Requirement —  $V_{GS(th)} = 4 \text{ V max}$
- Surface Mount Package on 16 mm Tape
- Available With Long Leads, Add -1 Suffix


**CASE 369A-10**  
**MTD2N20**

**CASE 369-06**  
**MTD2N20-1**
**MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	200	Vdc
Drain-Gate Voltage ( $R_{GS} = 1 \text{ M}\Omega$ )	$V_{DGR}$	200	Vdc
Gate-Source Voltage — Continuous	$V_{GS}$	$\pm 20$	Vdc
— Non-repetitive ( $t_p \leq 50 \mu\text{s}$ )	$V_{GSM}$	$\pm 40$	Vpk
Drain Current — Continuous	$I_D$	2	Adc
— Pulsed	$I_{DM}$	11	
Total Power Dissipation @ $T_C = 25^\circ\text{C}$	$P_D$	25	Watts
Derate above $25^\circ\text{C}$		0.2	$\text{W}/^\circ\text{C}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	$P_D$	1.25	Watts
Derate above $25^\circ\text{C}$		0.01	$\text{W}/^\circ\text{C}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (1)	$P_D$	1.75	Watts
Derate above $25^\circ\text{C}$		0.014	$\text{W}/^\circ\text{C}$
Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	-65 to +150	$^\circ\text{C}$

**THERMAL CHARACTERISTICS**

Thermal Resistance — Junction to Case	$R_{\theta JC}$	5	$^\circ\text{C}/\text{W}$
	$R_{\theta JA}$	100	$^\circ\text{C}/\text{W}$
		71.4	
— Junction to Ambient			
— Junction to Ambient (1)			

(1) These ratings are applicable when surface mounted on the minimum pad size recommended.

**Designer's Data for "Worst Case" Conditions** — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>				
Drain-Source Breakdown Voltage ( $V_{GS} = 0, I_D = 0.25 \text{ mA}$ )	$V_{(BR)DSS}$	200	—	Vdc
Zero Gate Voltage Drain Current ( $V_{DS} = \text{Rated } V_{DSS}, V_{GS} = 0$ ) ( $T_J = 125^\circ\text{C}$ )	$I_{DSS}$	—	1 10	$\mu\text{Adc}$
Gate-Body Leakage Current, Forward ( $V_{GSF} = 20 \text{ Vdc}, V_{DS} = 0$ )	$I_{GSSF}$	—	100	nAdc
Gate-Body Leakage Current, Reverse ( $V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0$ )	$I_{GSSR}$	—	100	nAdc

**ON CHARACTERISTICS\***

Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 1 \text{ mA}$ ) ( $T_J = 125^\circ\text{C}$ )	$V_{GS(th)}$	2 1.3	4.5 3.8	Vdc
Static Drain-Source On-Resistance ( $V_{GS} = 10 \text{ Vdc}, I_D = 1 \text{ Adc}$ )	$R_{DS(on)}$	—	1.5	Ohms
Drain-Source On-Voltage ( $V_{GS} = 10 \text{ V}$ ) ( $I_D = 2 \text{ Adc}$ ) ( $I_D = 1 \text{ Adc}, T_J = 100^\circ\text{C}$ )	$V_{DS(on)}$	—	3 2.5	Vdc
Forward Transconductance ( $V_{DS} = 15 \text{ V}, I_D = 1 \text{ A}$ )	$g_{FS}$	0.8	—	mhos

**DYNAMIC CHARACTERISTICS**

Input Capacitance	( $V_{DS} = 25 \text{ V}, V_{GS} = 0,$ $f = 1 \text{ MHz}$ ) See Figure 11	$C_{iss}$	220 (Typ)	—	pF
Output Capacitance		$C_{oss}$	60 (Typ)	—	
Reverse Transfer Capacitance		$C_{rss}$	10 (Typ)	—	

**SWITCHING CHARACTERISTICS\* ( $T_J = 100^\circ\text{C}$ )**

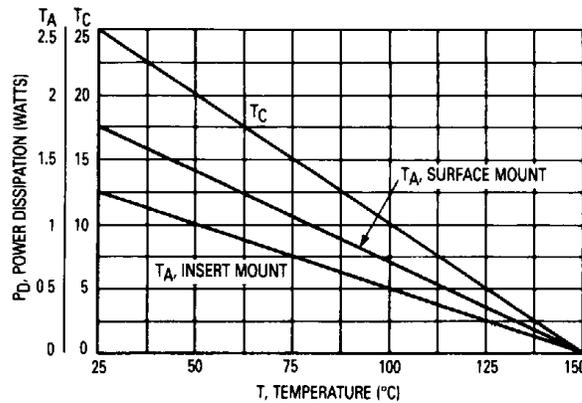
Turn-On Delay Time	( $V_{DD} = 25 \text{ V}, I_D = 1 \text{ A},$ $R_{gen} = 50 \text{ ohms}$ ) See Figures 13 and 14	$t_{d(on)}$	12 (Typ)	—	ns
Rise Time		$t_r$	18 (Typ)	—	
Turn-Off Delay Time		$t_{d(off)}$	35 (Typ)	—	
Fall Time		$t_f$	18 (Typ)	—	
Total Gate Charge	( $V_{DS} = 160 \text{ V},$ $I_D = 2 \text{ A}, V_{GS} = 10 \text{ V}$ ) See Figure 12	$Q_g$	6.4 (Typ)	12	nC
Gate-Source Charge		$Q_{gs}$	1.2 (Typ)	—	
Gate-Drain Charge		$Q_{gd}$	3 (Typ)	—	

**SOURCE DRAIN DIODE CHARACTERISTICS\***

Forward On-Voltage	$I_S = 2 \text{ A}, V_{GS} = 0$	$V_{SD}$	1.1 (Typ)	1.8	Vdc
Forward Turn-On Time	$I_S = 2 \text{ A}, dI_S/dt = 400 \text{ A}/\mu\text{s}$ $V_R = 50 \text{ V}$	$t_{on}$	Limited by stray inductance		
Reverse Recovery Time		$t_{rr}$	60 (Typ)	—	ns

\*Pulse Test Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

Figure 1. Power Derating



TYPICAL ELECTRICAL CHARACTERISTICS

Figure 2. On-Region Characteristics

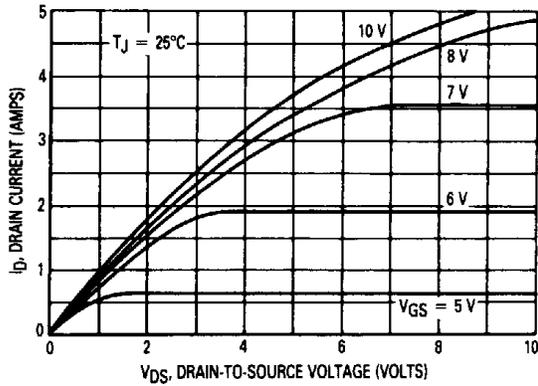


Figure 3. Gate-Threshold Voltage Variation With Temperature

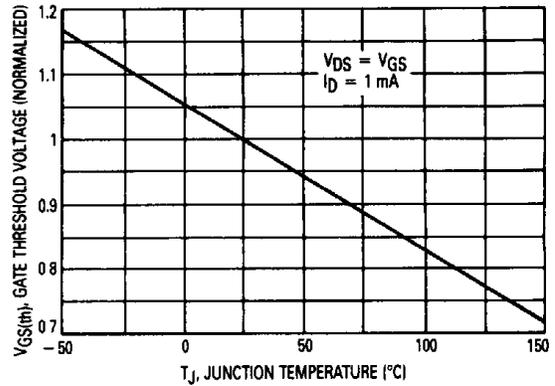


Figure 4. Transfer Characteristics

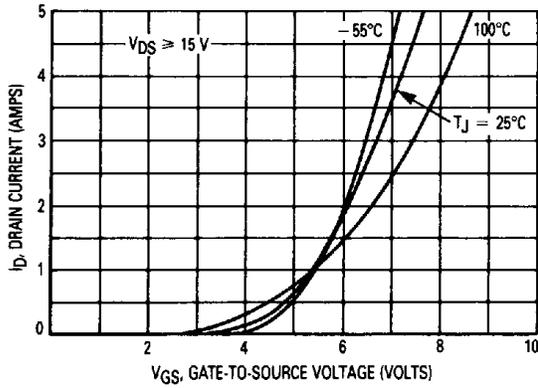


Figure 5. Breakdown Voltage Variation With Temperature

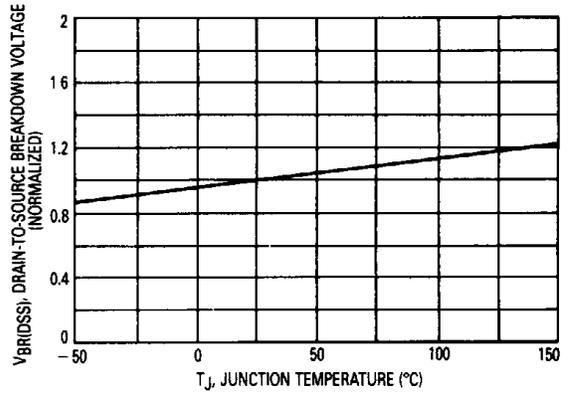


Figure 6. On-Resistance versus Drain Current

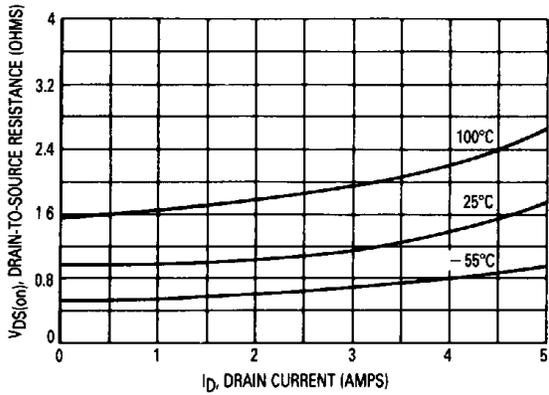
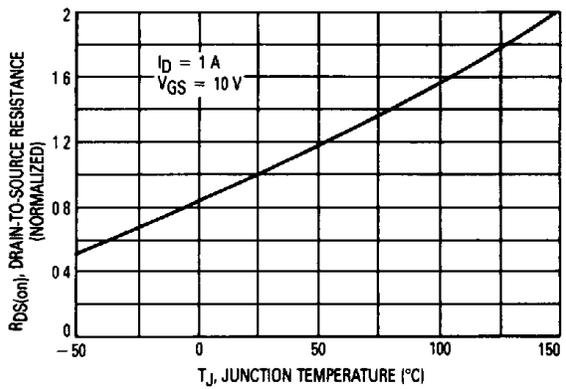


Figure 7. On-Resistance Variation With Temperature



3

Figure 8. Maximum Rated Forward Biased Safe Operating Area

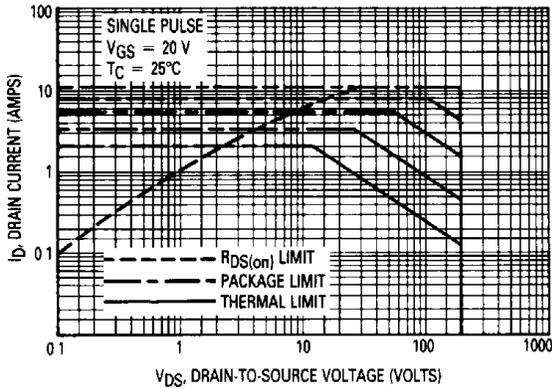
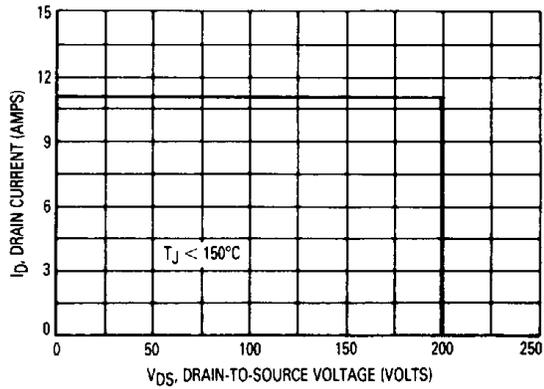


Figure 9. Maximum Rated Switching Safe Operating Area



**FORWARD BIASED SAFE OPERATING AREA**

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

**SWITCHING SAFE OPERATING AREA**

The switching safe operating area (SOA) of Figure 9 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current,  $I_{DM}$  and the breakdown voltage,  $V_{(BR)DSS}$ . The switching SOA shown in Figure 9 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

Figure 10. Thermal Response

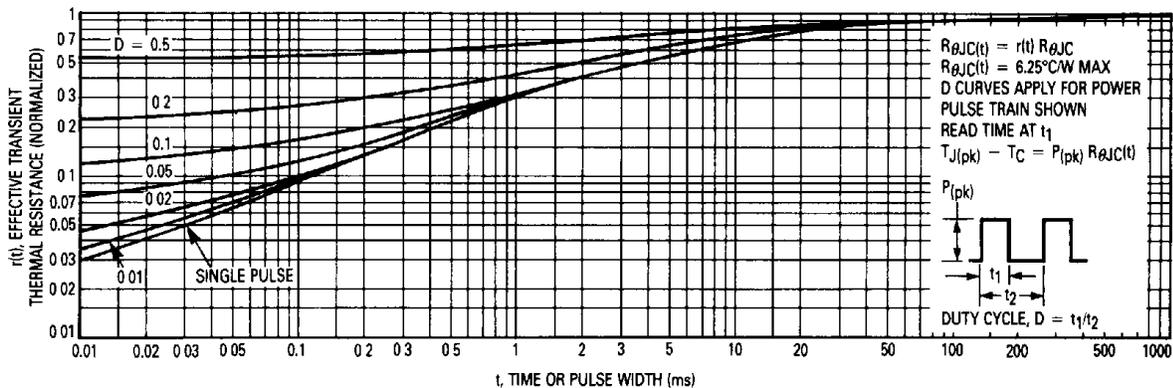


Figure 11. Capacitance Variation

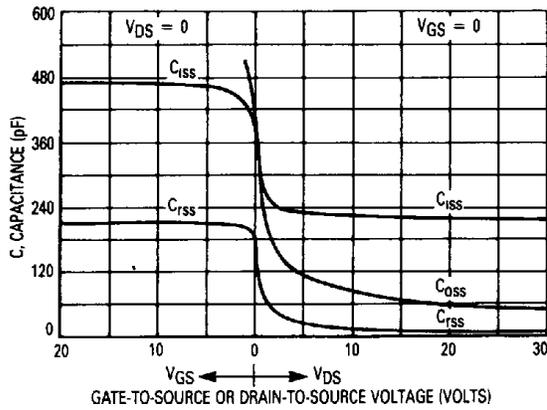
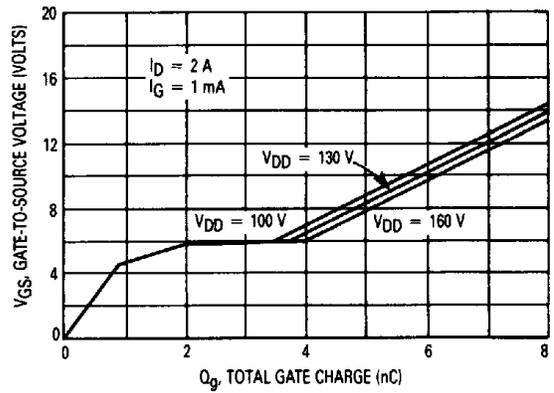


Figure 12. Gate Charge versus Gate-to-Source Voltage



3

RESISTIVE SWITCHING

Figure 13. Switching Test Circuit

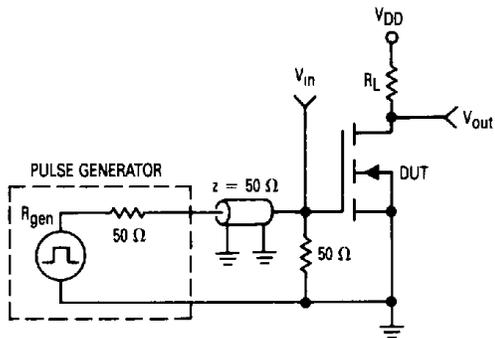


Figure 14. Switching Waveforms

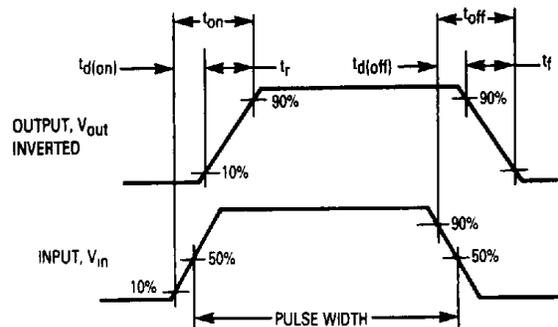


Figure 15. Switching Time versus Gate-to-Source Resistance

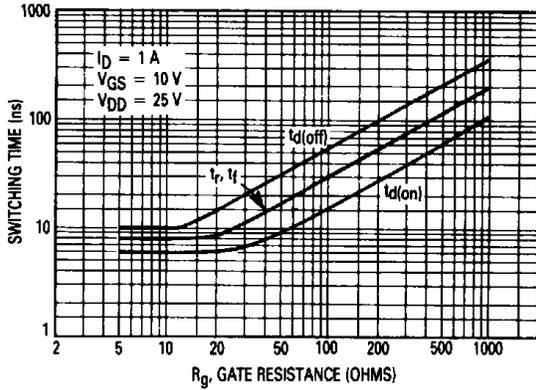


Figure 16. Diode Switching Waveform

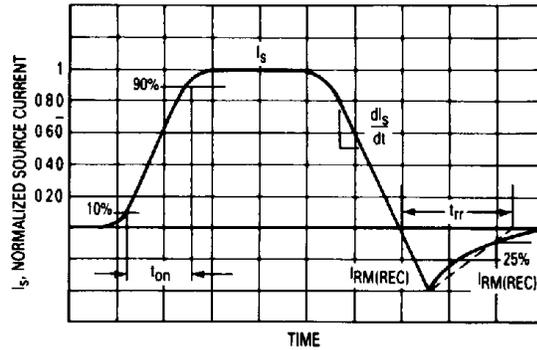


Figure 17. TMOS Diode Switching Test Circuit

NOTE: DUT is Shown as an N-Channel TMOS but can also be a P-Channel when appropriately connected DUT Driver is the same device as DUT Diode (or Complement for P-Channel DUT Diode)

